

CRMKTL3005CC

N-Channel 30V, 4.5mΩ Typ. Power MOSFET

Description

Features

• 30V, 85A

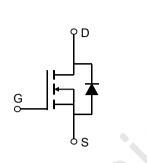
 $R_{DS(ON)}$ Typ = 4.5m Ω @ V_{GS} = 10V

 $R_{DS(ON)}$ Typ = 5.6m Ω @ V_{GS} = 4.5V

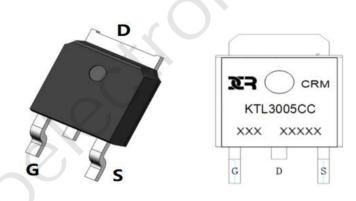
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- 100% UIS TESTED!
- 100% ΔVds TESTED!

Application

- Load Switch
- PWM Application
- Power Management



Schematic Diagram



Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMKTL3005CC	CRMKTL3005CC	TO-252-3L	TAPING	13"	2500	25000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V _{DS}	Drain-to-Source Voltage		30	V
V _{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	$T_{C} = 25^{\circ}C$	85	А
Ι _D		T _C = 100°C	51	А
I _{DM}	Pulsed Drain Current ⁽¹⁾		340	А
E _{AS}	Single Pulsed Avalanche Energy ⁽²⁾		77	mJ
P _D	Power Dissipation	T _C = 25°C	72.7	W
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case		1.72	°C/W
Τ _J , Τ _{stg}	Junction & Storage Temperature Range		-55 to 150	°C



Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Chara	acteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 30V, V _{GS} = 0V	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics				6	
V _{GS(th)}	Gate Threshold Voltage	V_{DS} = V_{GS} , I_D = 250 μ A	1	1.5	2	V
D		V_{GS} = 10V, I_{D} = 20A	-	4.5	5.9	mΩ
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽³⁾	V _{GS} = 4.5V, I _D = 15A	-	5.6	7.3	mΩ
Dynamic	Characteristics		(
C _{iss}	Input Capacitance		-	1900	-	pF
C _{oss}	Output Capacitance	V _{GS} = 0V, V _{DS} = 15V, f = 1MHz	Χ-	197	-	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112		165	-	pF
Q _g	Total Gate Charge	0	<u> </u>	35	-	nC
Q_gs	Gate Source Charge	$V_{GS} = 0$ to 10V $V_{DS} = 15V$, $I_{D} = 30A$) -	7	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} = 10V, 1 _D = 30A	-	8	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime		-	9	-	ns
t _r	Turn-On Rise Time	V _{GS} = 10V, V _{DD} = 15V	-	18	-	ns
$t_{d(off)}$	Turn-Off DelayTime	I_D = 30A, R_{GEN} = 3 Ω	-	28	-	ns
t _f	Turn-Off Fall Time		-	10	-	ns
Drain-So	urce Diode Characteristics and I	Max Ratings				
I _s	Maximum Continuous Drain to Source D	iode Forward Current	-	-	85	А
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	340	А
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _S = 20A	-	-	1.2	V
Notes:	1. Repetitive Rating: Pulse Width Limited by Maxir	num Junction Temperature.				

2. E_{AS} condition: Starting T_J=25°C, V_{DD}=15V, V_G=10V, R_G=25ohm, L=0.5mH, I_{AS}=17.5A

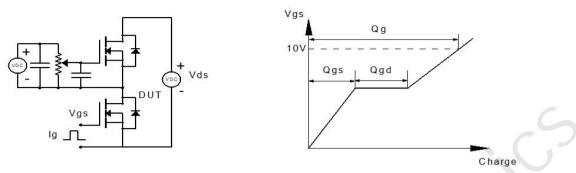
4. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



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Test Circuit





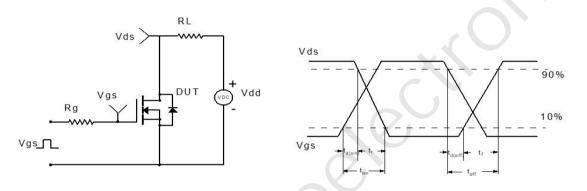


Figure 2: Resistive Switching Test Circuit & Waveform

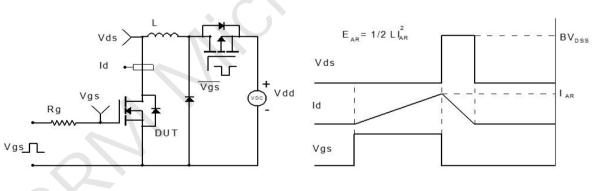


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

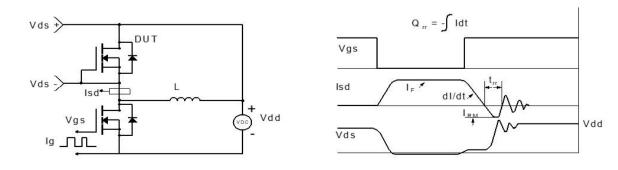


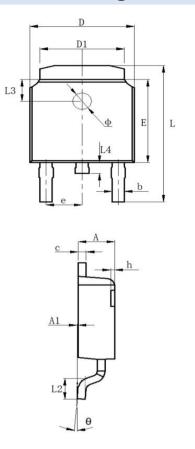
Figure 4: Diode Recovery Test Circuit & Waveform

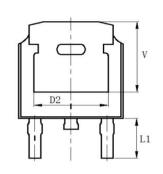


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Package Mechanical Data(TO-252-3L)





Cumbel.	Dimensions In Millimeters		
Symbol	Min.	Max.	
А	2.200	2.400	
A1	0.000	0.127	
b	0.600	0.860	
с	0.460	0.580	
D	6.500	6.700	
D1	5.100	5.460	
D2	4.830	REF.	
E	6.000	6.300	
е	2.186	2.386	
L.	9.712	10.312	
L1	2.900	REF.	
L2	1.400	1.700	
L3	1.600 REF.		
L4	0.600	1.000	
Φ	1.100	1.300	
θ	0°	8°	
h	0.000	0.300	
V	5.250 REF.		

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